SN54F153, SN74F153
DUAL 1-OF-4 DATA SELECTORS/MULTIPLEXERS

SDFS052A – D2932, MARCH 1987 – REVISED OCTOBER 1993

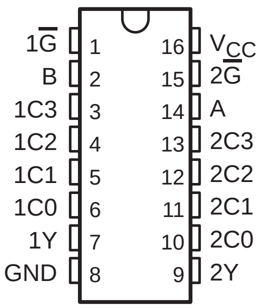
- **Permits Multiplexing From N Lines to One Line**
- **Performs Parallel-to-Serial Conversion**
- **Strobe (Enable) Line Provided for Cascading (N Lines to N Lines)**
- **Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs**

description

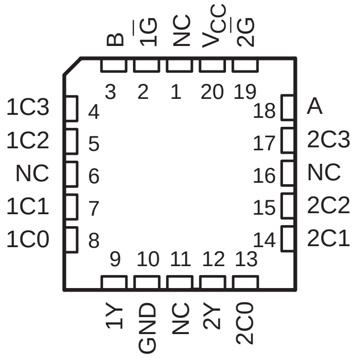
These data selectors/multiplexers contain inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate strobe ($\overline{\mathrm{G}}$) inputs are provided for each of the two 4-line sections.

The SN54F153 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74F153 is characterized for operation from 0°C to 70°C.

SN54F153 . . . J PACKAGE
SN74F153 . . . D OR N PACKAGE
(TOP VIEW)



SN54F153 . . . FK PACKAGE
(TOP VIEW)



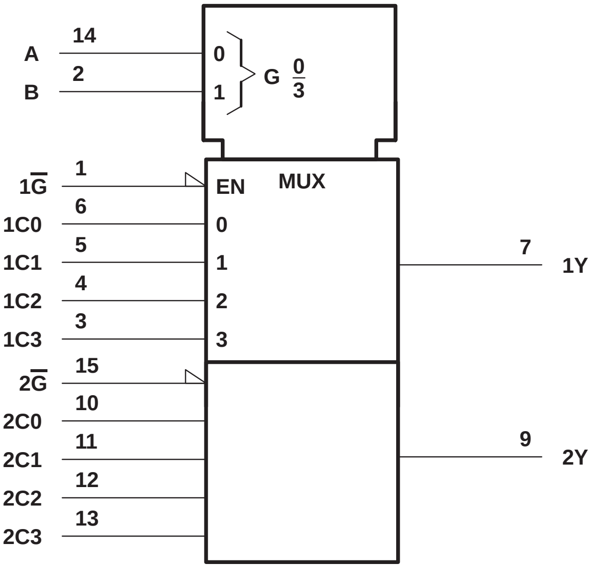
NC – No internal connection

FUNCTION TABLE

INPUTS						STROBE $\overline{\mathrm{G}}$	OUTPUT Y
SELECT		**DATA**					
B	**A**	**C0**	**C1**	**C2**	**C3**		
X	X	X	X	X	X	H	L
L	L	L	X	X	X	L	L
L	L	H	X	X	X	L	H
L	H	X	L	X	X	L	L
L	H	X	H	X	X	L	H
H	L	X	X	L	X	L	L
H	L	X	X	H	X	L	H
H	H	X	X	X	L	L	L
H	H	X	X	X	H	L	H

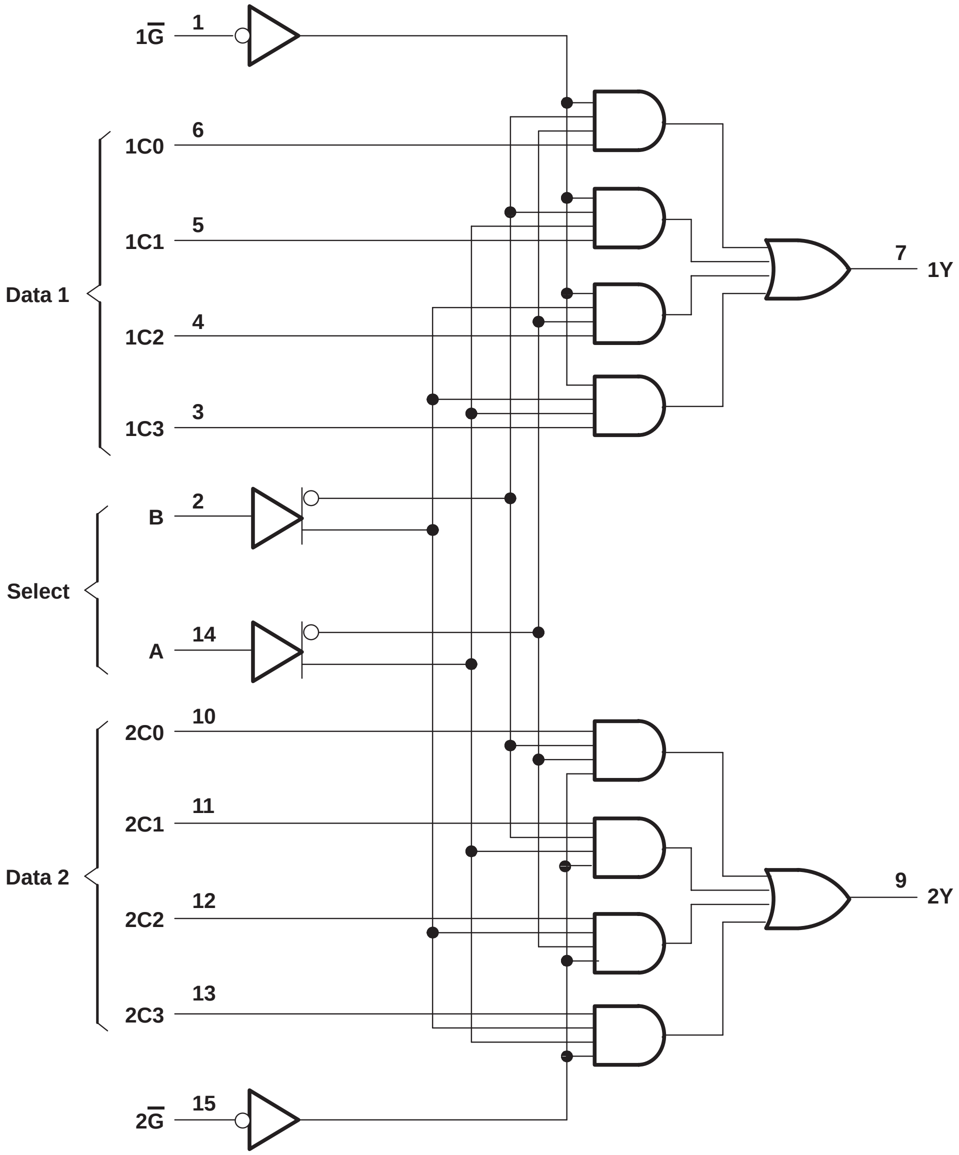
Select inputs A and B are common to both sections.

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the D, J, and N packages.

logic diagram (positive logic)



Pin numbers shown are for the D, J, and N packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range (see Note 1)	–1.2 V to 7 V
Input current range	–30 mA to 5 mA
Voltage range applied to any output in the high state	–0.5 V to V_{CC}
Current into any output in the low state	40 mA
Operating free-air temperature range: SN54F153	–55°C to 125°C
SN74F153	0°C to 70°C
Storage temperature range	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage rating may be exceeded provided that the input current rating is observed.

recommended operating conditions

		SN54F153			SN74F153			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{IK}	Input clamp current			–18			–18	mA
I_{OH}	High-level output current			– 1			– 1	mA
I_{OL}	Low-level output current			20			20	mA
T_A	Operating free-air temperature	–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN54F153			SN74F153			UNIT
			MIN	TYP[‡]	MAX	MIN	TYP[‡]	MAX	
V_{IK}	V_{CC} = 4.5 V,	I_I = –18 mA			–1.2			–1.2	V
V_{OH}	V_{CC} = 4.5 V,	I_{OH} = – 1 mA	2.5	3.4		2.5	3.4		V
	V_{CC} = 4.75 V,	I_{OH} = – 1 mA				2.7			
V_{OL}	V_{CC} = 4.5 V,	I_{OL} = 20 mA		0.3	0.5		0.3	0.5	V
I_I	V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}	V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	µA
I_{IL}	V_{CC} = 5.5 V,	V_I = 0.5 V			– 0.6			– 0.6	mA
I_{OS}[§]	V_{CC} = 5.5 V,	V_O = 0	–60		–150	–60		–150	mA
I_{CC}	V_{CC} = 5.5 V,	V_I = 0		12	20		12	20	mA

[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C.

[§] Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 5 V, C_L = 50 pF, R_L = 500 Ω, T_A = 25°C			V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R_L = 500 Ω, T_A = MIN to MAX†				UNIT
			′F153			SN54F153		SN74F153		
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	A or B	Y	3.7	7.7	10.5	3.7	14	3.7	12	ns
t_{PHL}			2.7	6.6	9	2.7	11	2.7	10.5	
t_{PLH}	$\overline{G}$	Y	3.7	6.7	9	3.7	11.5	3.7	10.5	ns
t_{PHL}			2.2	5.3	7	1.7	9	1.7	8	
t_{PLH}	C	Y	2.2	4.9	7	1.7	9	2.2	8	ns
t_{PHL}			2.2	4.7	6.5	1.7	8	1.7	7.5	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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